

<b>Notice of References Cited</b>	Application/Control No. 10/527,803	Applicant(s)/Patent Under Reexamination RAICK ET AL.	
	Examiner Mark L. Shevin	Art Unit 1709	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,798,007	08-1998	Boyer et al.	148/627
	B	US-			
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	E	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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